

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/532,845	LU ET AL.	
	Examiner	Art Unit	
	Y. Lee	2621	

Search Notes



Application/Control No.

10/532,845

Examiner

Y. Lee

**Applicant(s)/Patent under
Reexamination**

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Art Unit

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INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)